

### Introduction to Beam Instrumentation

### CAS 2015

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# 

#### • What do we mean by beam instrumentation?

- The "eyes" of the machine operators
  - i.e. the instruments that observe beam behaviour
  - An accelerator can never be better than the instruments measuring its performance!

#### • What does work in beam instrumentation entail?

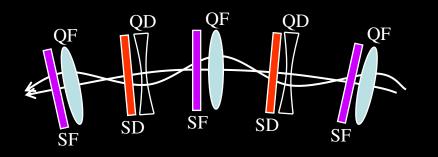
- Design, construction & operation of instruments to observe particle beams
- R&D to find new or improve existing techniques to fulfill new requirements
- A combination of the following disciplines
  - Applied & Accelerator Physics; Mechanical, Electronic & Software Engineering
- A fascinating field of work!

#### • What beam parameters do we measure?

- Beam Position
  - Horizontal and vertical throughout the accelerator
- Beam Intensity (& lifetime measurement for a storage ring/collider)
  - Bunch-by-bunch charge and total circulating current
- Beam Loss
  - Especially important for high brightness and superconducting machines
- Beam profiles
  - Transverse and longitudinal distribution

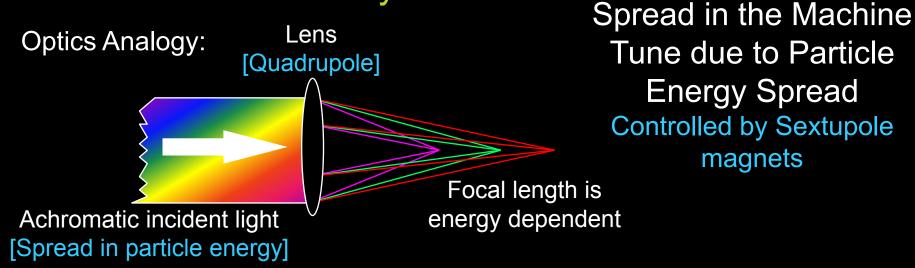


#### Machine Tune



Characteristic Frequency of the Magnetic Lattice Given by the strength of the Quadrupole magnets

#### Machine Chromaticity



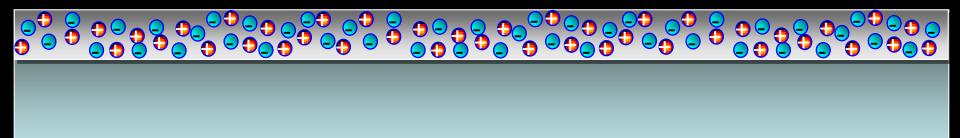
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# The Typical Instruments

- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
  - beam current transformers
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionisation and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- Beam Loss
  - ionisation chambers or pin diodes
- Machine Tune and Chromaticity
  - in Beam Diagnostics lecture of tomorrow

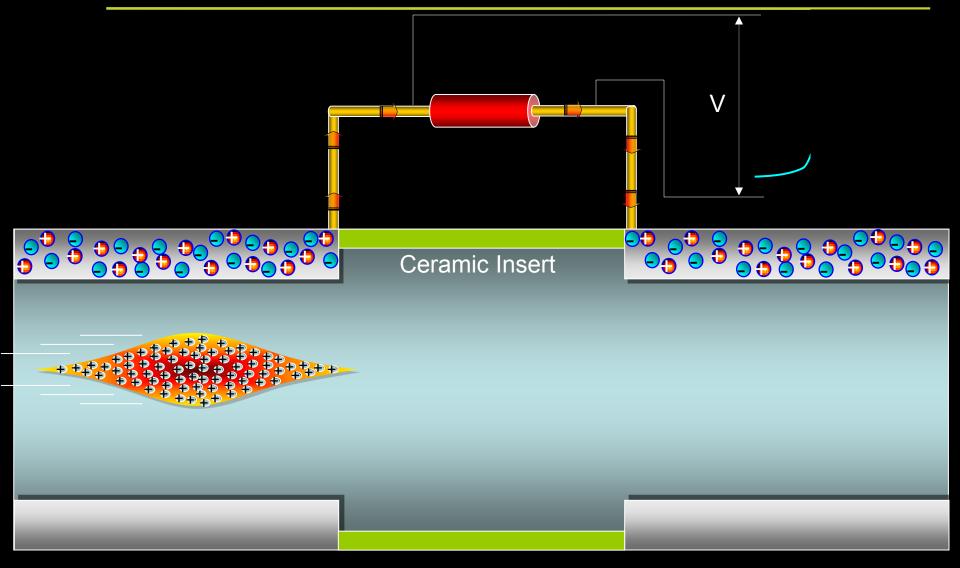


#### Measuring Beam Position – The Principle



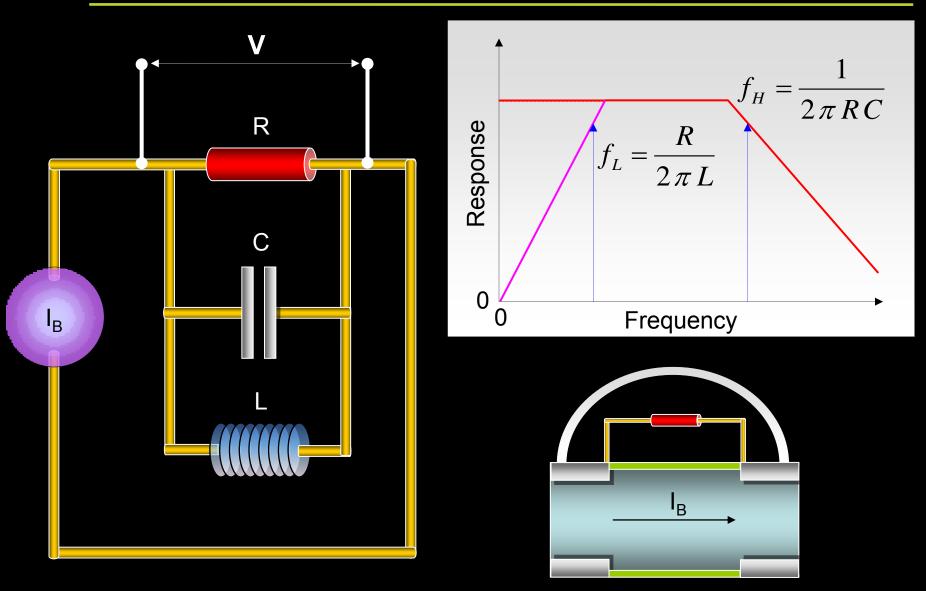
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### Wall Current Monitor – The Principle



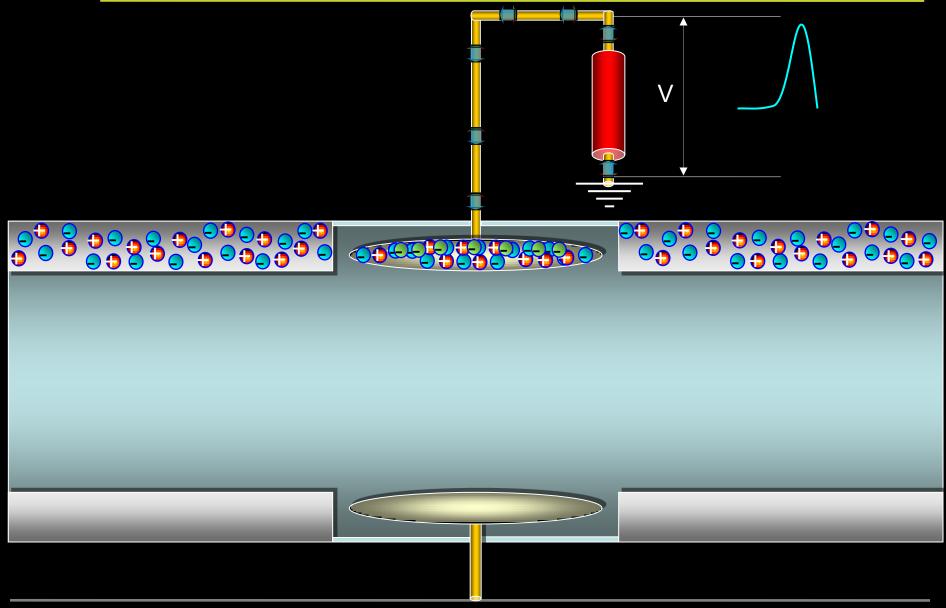


#### Wall Current Monitor – Beam Response



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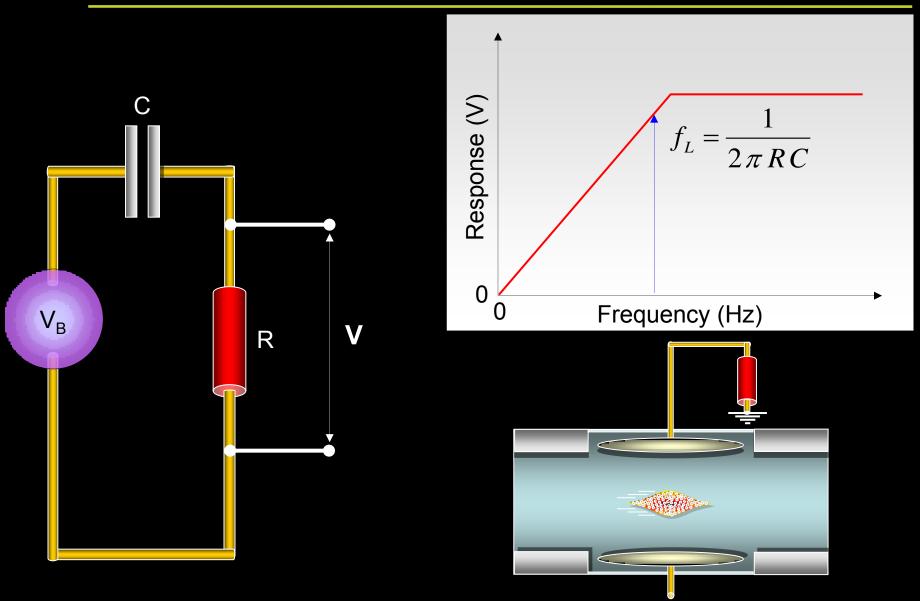
#### **Electrostatic Monitor – The Principle**



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#### **Electrostatic Monitor – Beam Response**



### **Electrostatic Beam Position Monitor** $\mathbf{V}$ 0 0 0 0 0 0 0 ° ° ° ° ° • • 2.2 0 -)

# Electrostatic Pick-up – Button

#### ✓ Low cost $\Rightarrow$ most popular × Non-linear

 requires correction algorithm when beam is off-centre

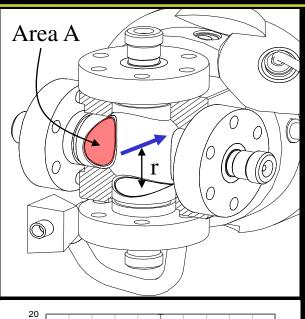
For Button with Capacitance  $C_e \&$  Characteristic Impedance  $R_0$ 

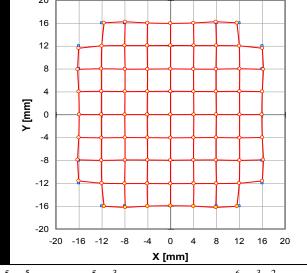
Transfer Impedance:

$$Z_{T(f>>f_c)} = \frac{A}{(2\pi r) \times c \times C_e}$$

Lower Corner Frequency:

$$f_L = \frac{1}{2 \pi R_0 C_e}$$





 $X = 2.30 \cdot 10^{-5} X_1^{5} + 3.70 \cdot 10^{-5} X_1^{3} + 1.035 X_1 + 7.53 \cdot 10^{-6} X_1^{3} Y_1^{2} + 1.53 \cdot 10^{-5} X_1 Y_1^{4}$ 

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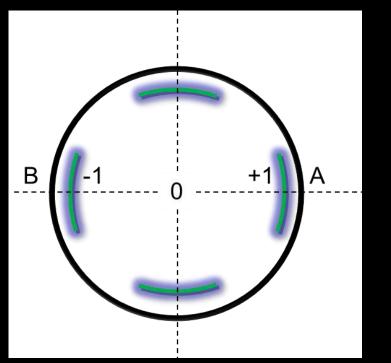
### Normalising the Position Reading

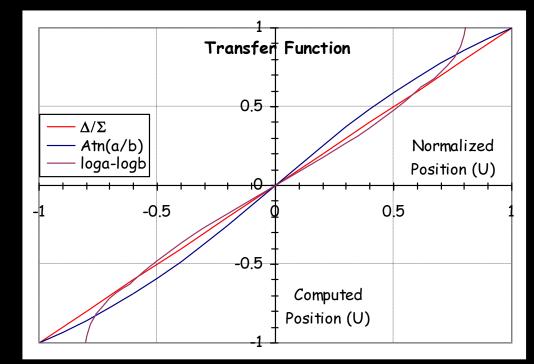
- To make it independent of intensity
- 3 main methods:

  - Phase



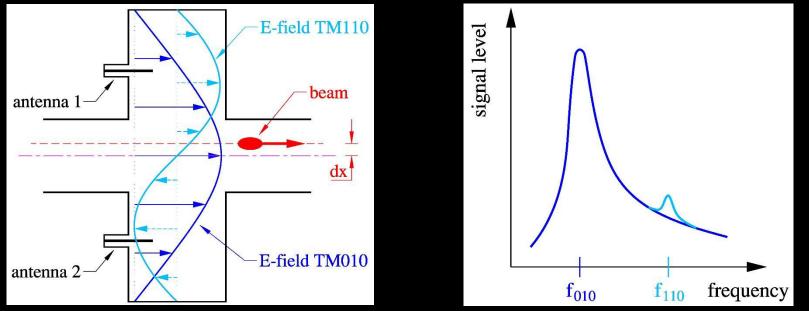
- : Arctan( $V_A / V_B$ )
- Logarithm :  $Log(V_A) Log(V_B)$





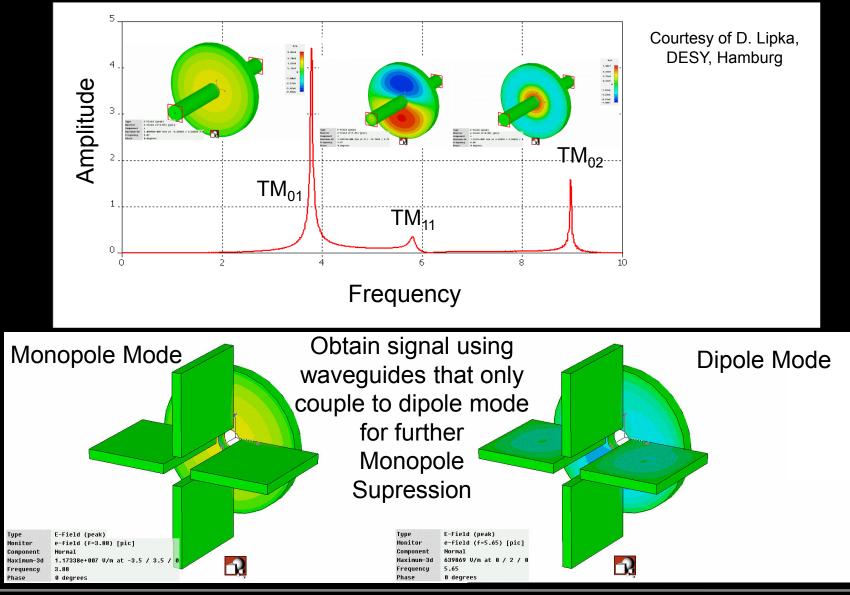
#### Improving Precision for Next Generation Accelerators

- BPM electrodes typically give "intensity signals" with some position dependence!
  - Need to remove intensity content to get to the position
  - Difficult to do electronically without some intensity information leaking through
    - When looking for small differences this leakage can dominate the measurement
- Solution cavity BPM allowing sub micron resolution
  - Design the detector to collect only the difference signal
    - Dipole Mode TM<sub>11</sub> proportional to POSITION OFFSET (& intensity)
    - Shifted in frequency with respect to intensity dependent Monopole Mode TM<sub>01</sub>



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# Cavity Beam Position Monitors



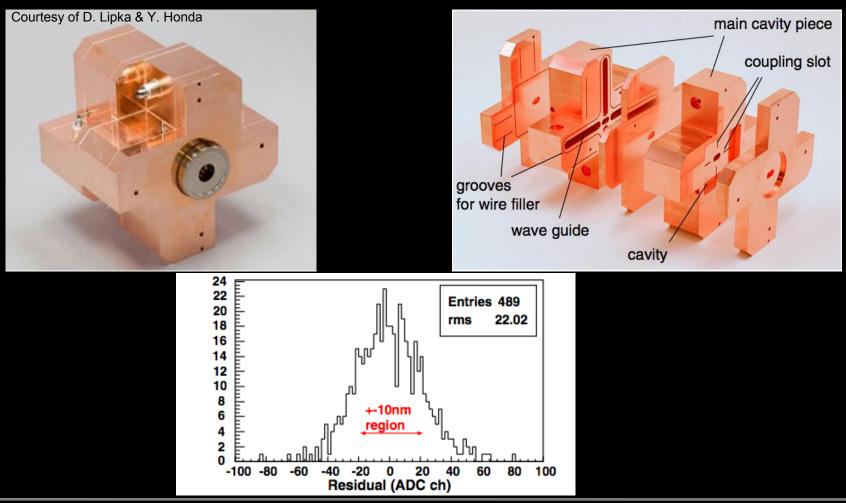
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# Today's State of the Art BPMs

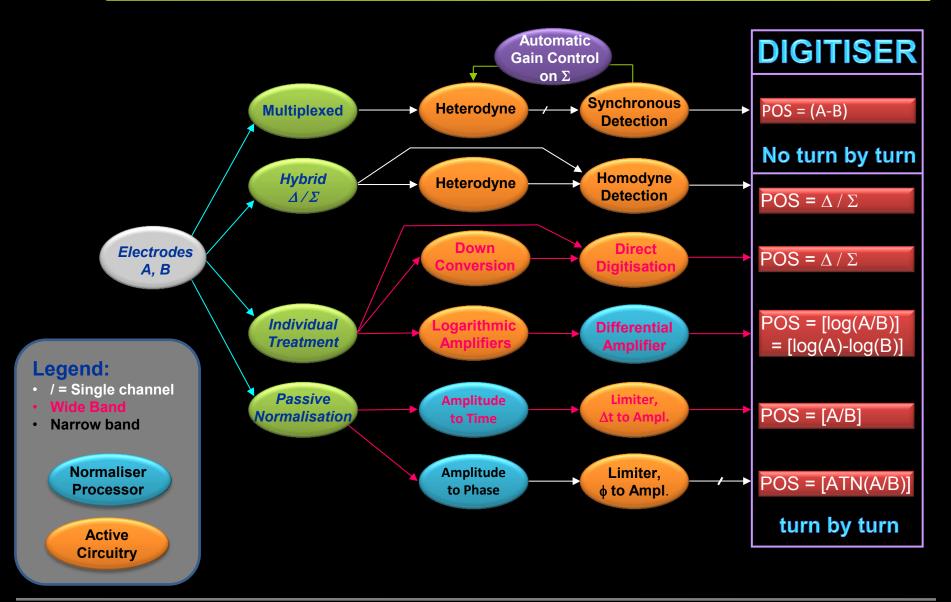
#### Prototype BPM for ILC Final Focus

- Required resolution of 2nm (yes nano!) in a 6 × 12mm diameter beam pipe
- Achieved World Record (so far!) resolution of 8.7nm at ATF2 (KEK, Japan)



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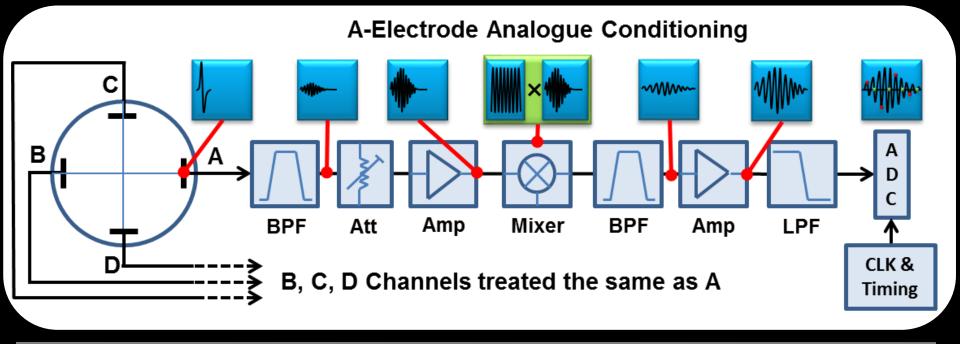
# Processing System Families



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### Modern BPM Read-out Electronics

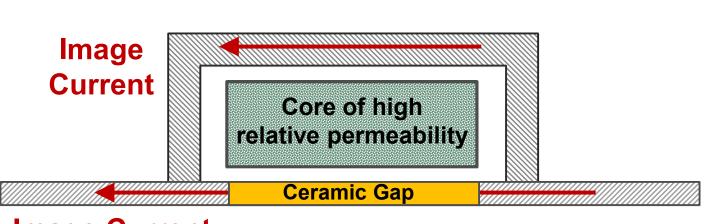
- Based on the individual treatment of the electrode signals
  - Use of frequency domain signal processing techniques
    - Developed for telecommunications market
  - Rely on high frequency & high resolution analogue to digital converters
    - Minimising analogue circuitry
    - Frequency down-conversion used if necessary to adapt to ADC sampling rate
    - All further processing carried out in the subsequent digital electronics



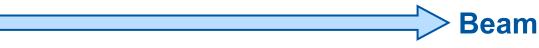
# The Typical Instruments

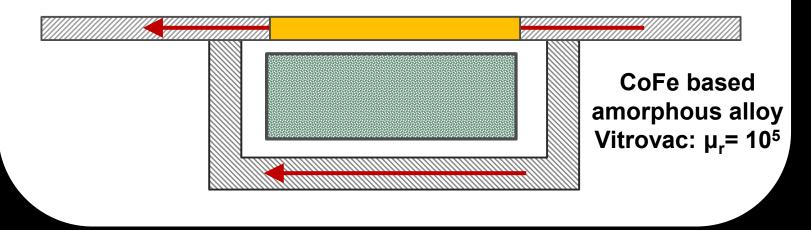
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  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
  - beam current transformers
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
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# AC (Fast) Current Transformers



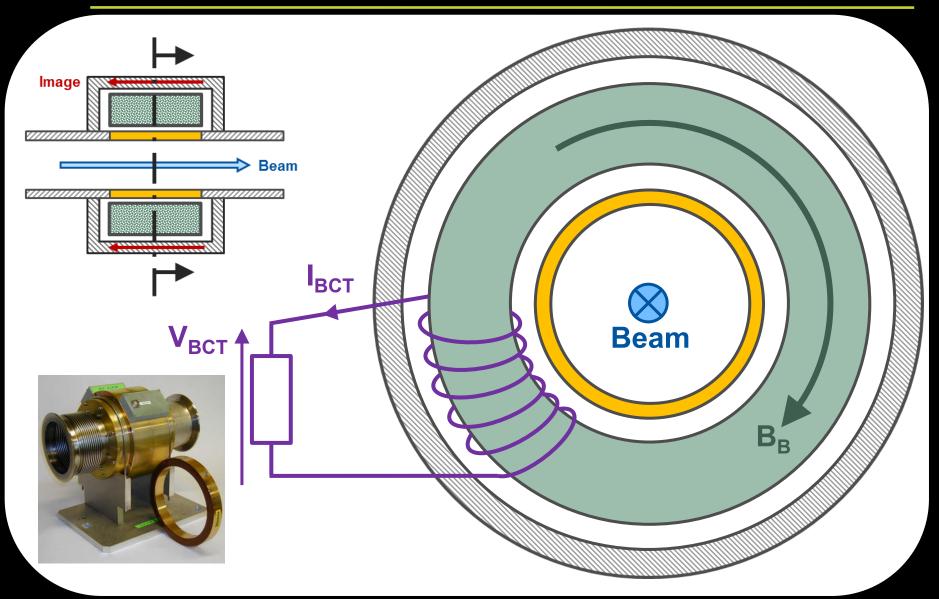
#### Image Current





# AC (Fast) Current Transformers

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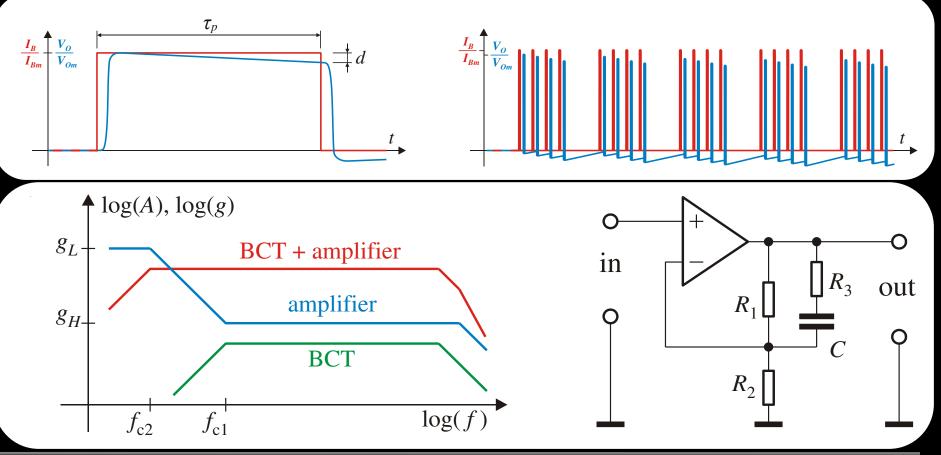


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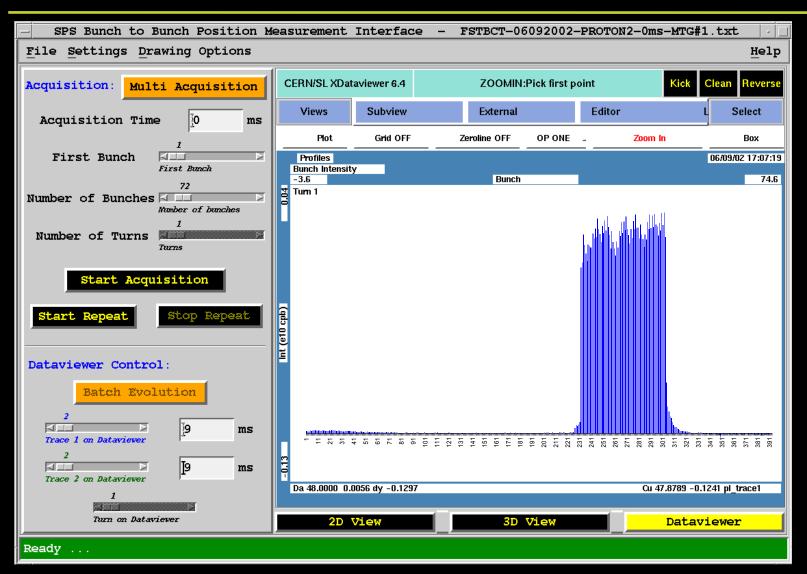
### AC (Fast) Transformer Response

#### Low cut-off

- Impedance of secondary winding decreases at low frequency
- Results in signal droop and baseline shift
- Mitigated by baseline restoration techniques (analogue or digital)



### What one can do with such a System



#### Bad RF Capture of a single LHC Batch in the SPS (72 bunches)

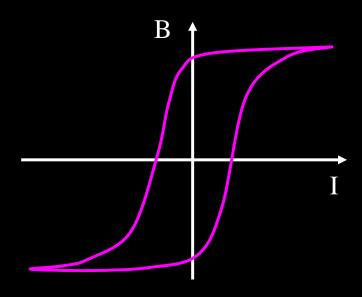
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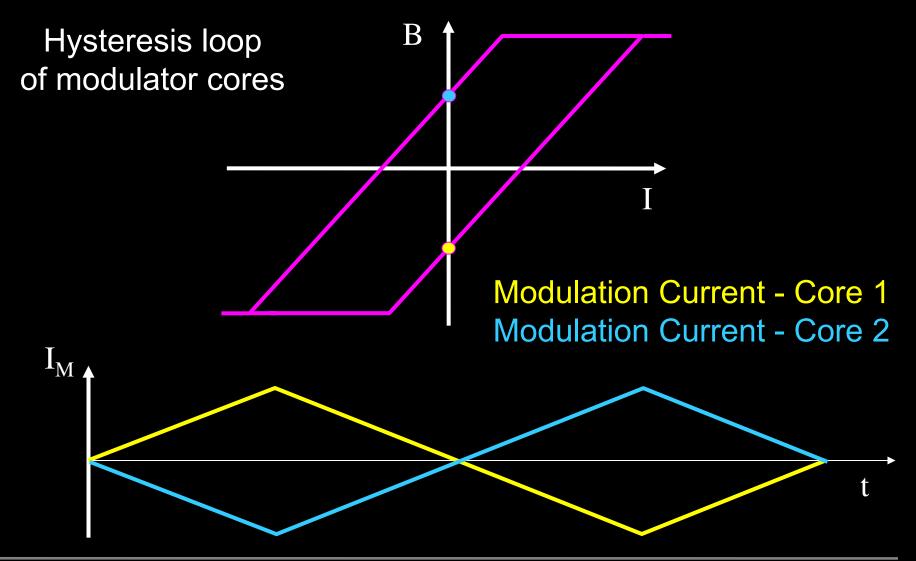
# The DC transformer

- AC transformers can be extended to very low frequency but not to DC (no dl/dt !)
- DC measurement is required in storage rings
- To do this:
  - Take advantage of non-linear magnetisation curve
  - Use 2 identical cores modulated with opposite polarities

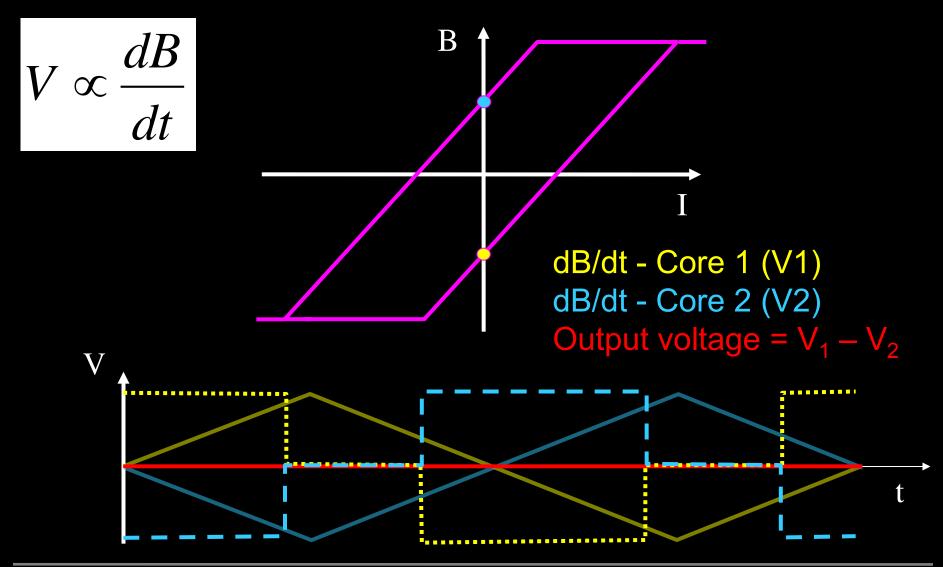




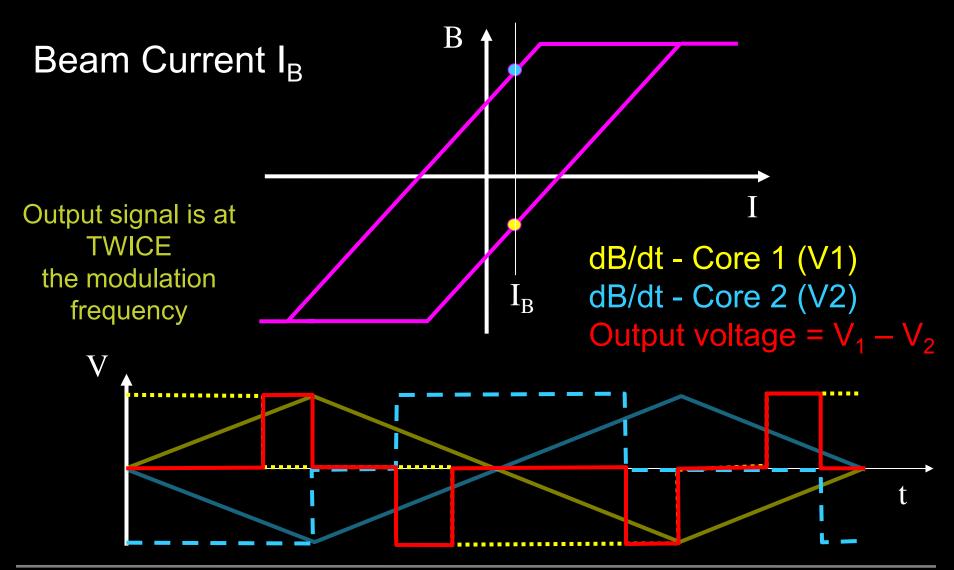
### DCCT Principle – Case 1: no beam



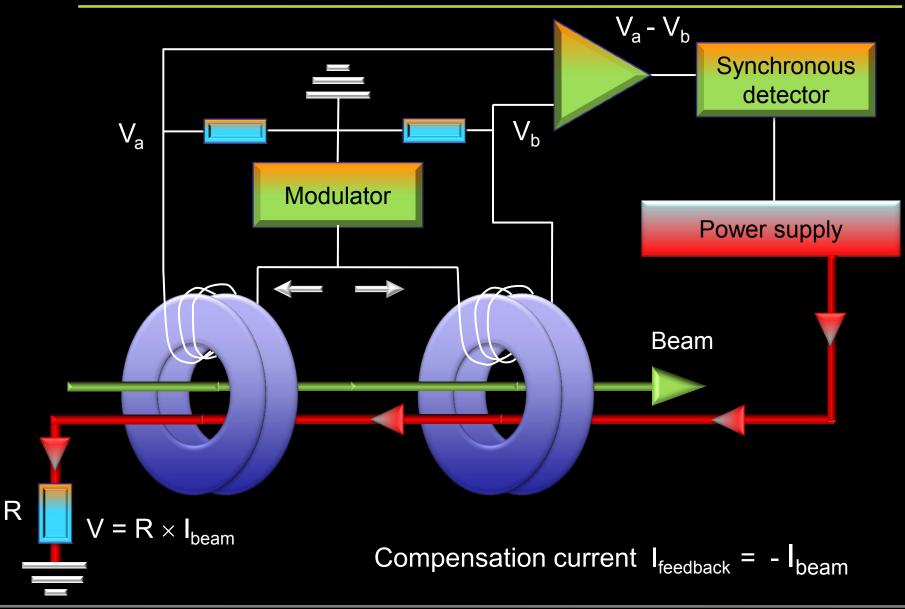
### DCCT Principle – Case 1: no beam



# DCCT Principle – Case 2: with beam



### Zero Flux DCCT Schematic



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### **BCTs in Operation**

- Provide the general visual diagnostics for most accelerators
- LHC Operation Pages
  - Total intensity measurement
  - Lifetime calculation



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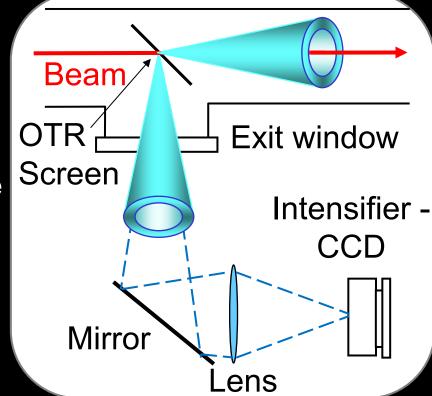
### **Beam Profile Monitoring using Screens**

#### Screen Types

- Luminescence / Scintillating Screens
  - Destructive (thick) but work with low intensities
- Optical Transition Radiation (OTR) screens
  - Much less destructive (thin) but require higher energy / intensity beam

#### • OTR

- Radiation emitted when a charged particle goes through an interface with different dielectric constants
- Surface phenomenon allows use of very thin screens (~10µm)
  - Can use multiple screens with single pass in transfer lines
  - Can leave it in for hundreds of turns e.g. for injection matching

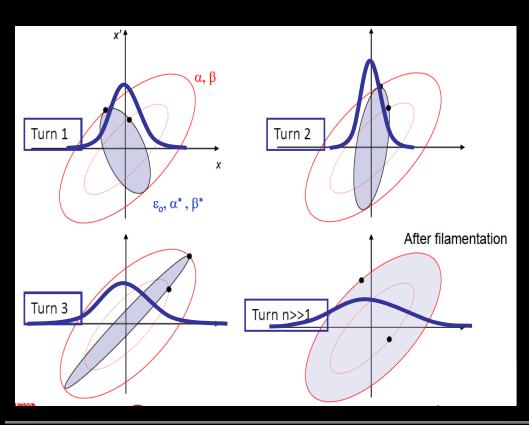


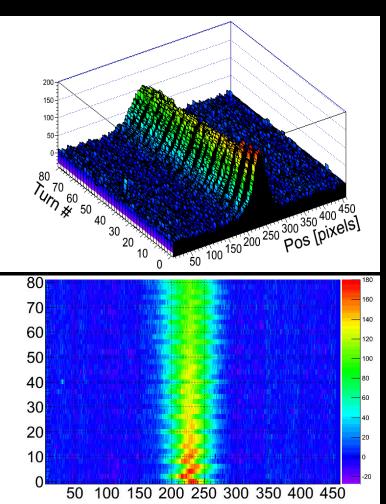


### Measurements with Screens

#### Injection matching measurements with OTR

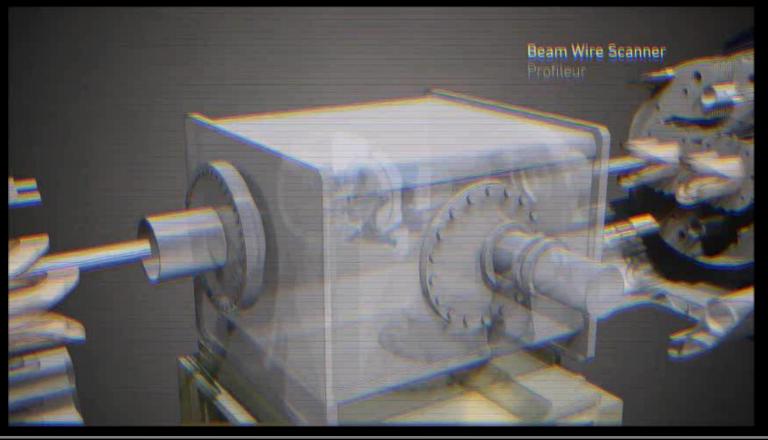
- Filamentation
- Machine Settings Mismatch



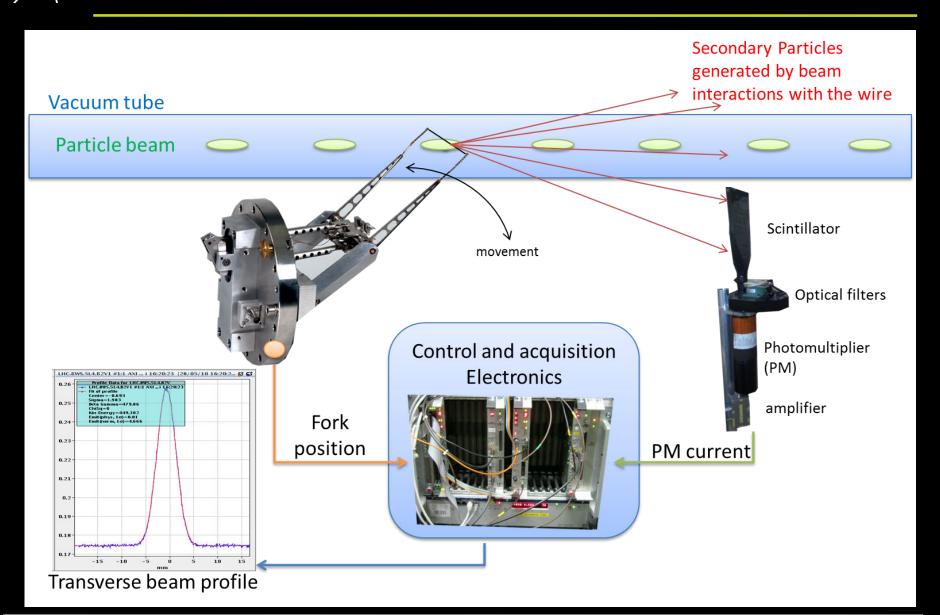


### Beam Profile Monitoring using Wire-Scanners

- A thin wire is moved across the beam
  - Has to move fast to avoid excessive heating of the wire
- Detection
  - Secondary particle shower detected outside vacuum chamber using scintillator/photo-multiplier
- Correlating wire position with detected signal gives the beam profile



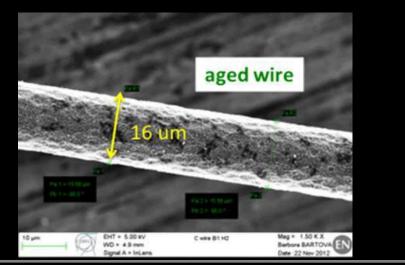
### Beam Profile Monitoring using Wire-Scanners

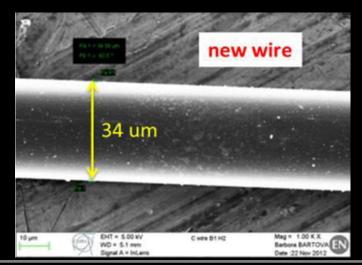


# Limitation of WireScanners

#### Wire Breakage – why?

- Brittle or Plastic failure (error in motor control)
- Melting/Sublimation (main intensity limit)
  - Due to energy deposition in wire by proton beam
- Temperature evolution depends on
  - Heat capacity, which increases with temperature!
  - Cooling (radiative, conductive, thermionic, sublimation)
    - Negligible during measurements (Typical scan 1 ms & cooling time constant ~10-15 ms)
- Wire Choice
  - Good mechanical properties, high heat capacity, high melting/sublimation point
  - E.g. Carbon which sublimates at 3915K

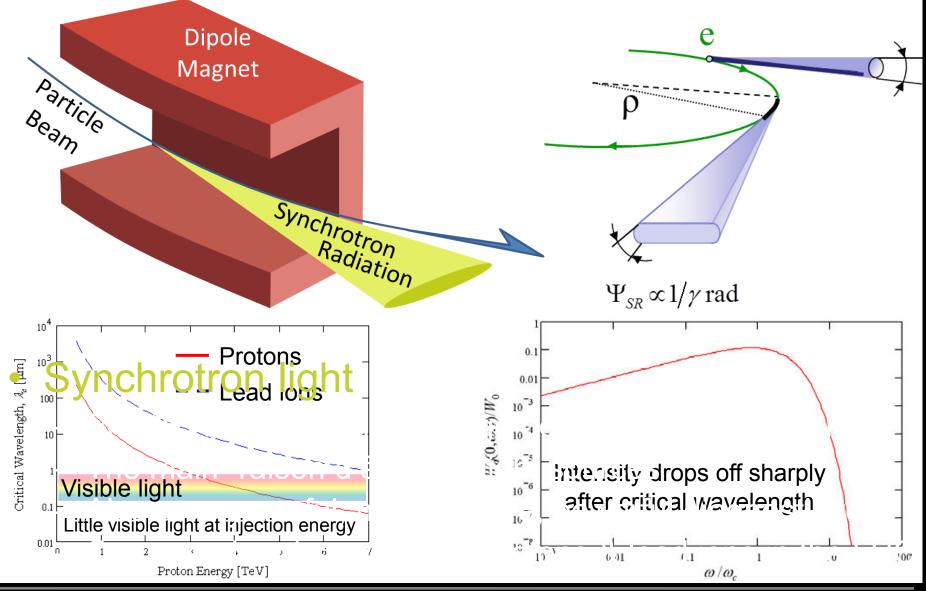




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# Synchrotron Light Monitors



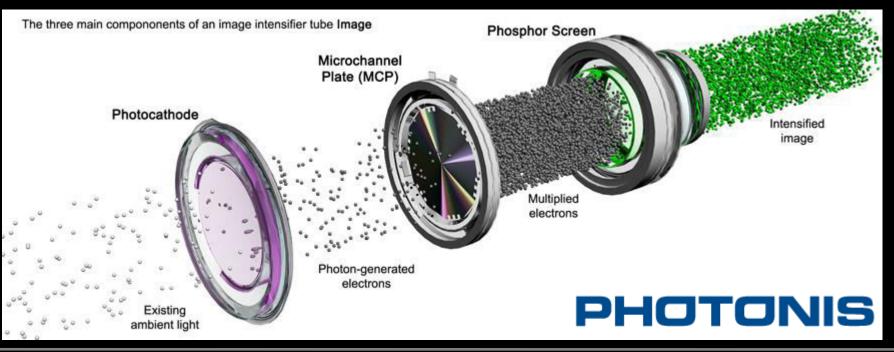
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### Synchrotron Light Image Acquisition

#### Using various cameras

- Standard CCD cameras for average beam size measurements
- Gated intensified camera
  - For bunch by bunch diagnostics
- Streak cameras
  - For short bunch diagnostics



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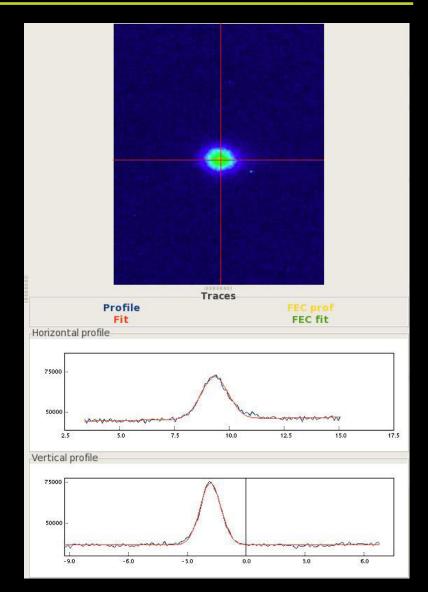
# Synchrotron Light Imaging

### Proton Beam Example

- LHC single bunch ~1.1e11p @ 3.5 TeV
- Acquistion accumulated over 4 turns at 200Hz

### Limitations

- Aberrations
  - Mitigated by careful design
- Diffraction
  - Need to go to lower wavelengths as the beam size becomes smaller

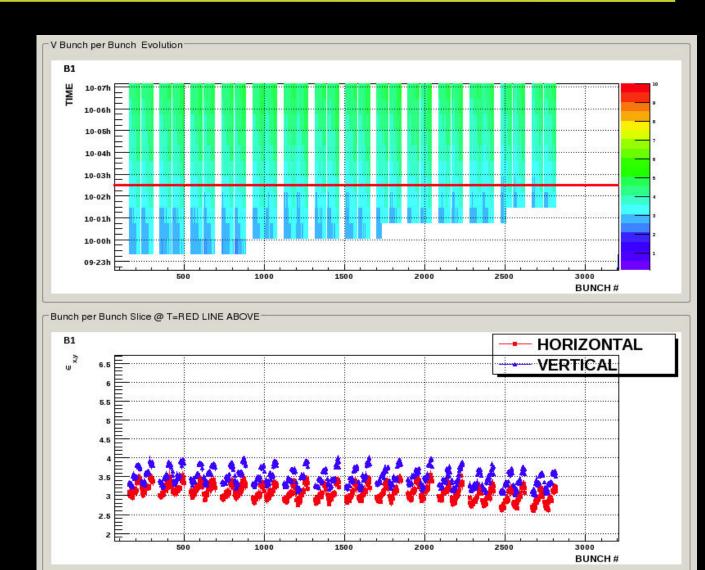


## Bunch by Bunch Profile Measurement

### Diagnostics

 Allows diagnosis of systematic emittance patterns from the LHC injectors

 In this case variations in the emittance from the 4 different PS Booster rings



# Measuring Ultra Short Bunches

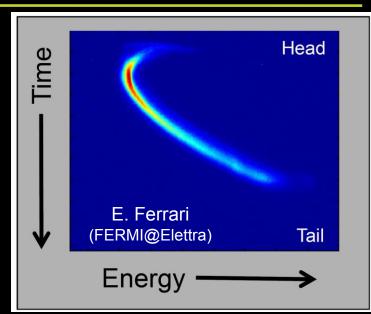
- Next Generation FELs
  & Linear Colliders
  - Use ultra short bunches to increase brightness or improve luminosity
- How do we measure such short bunches?
  - Direct Observation
    - Produce light & observe with dedicated instruments
    - Use of RF techniques
    - Use laser pulses and sampling techniques
  - Indirect Calculation
    - Reconstruct bunch length from frequency spectrum
      - Either directly from the bunch or through its radiation spectrum

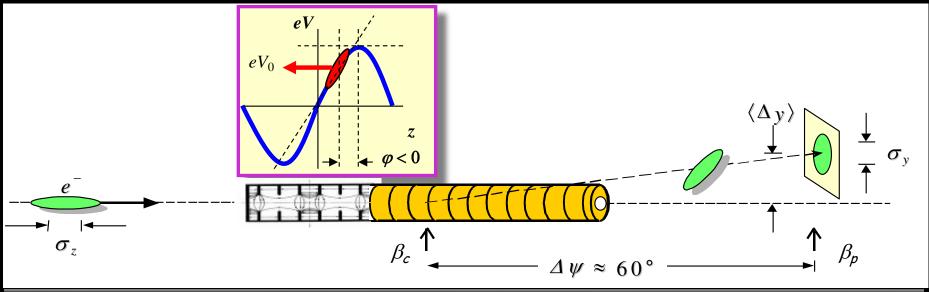
p⁺ @ LHC	250ps	
H <sup>-</sup> @ SNS	100ps	
e⁻ @ ILC	500fs	
e <sup>-</sup> @ CLIC	130fs	
e <sup>-</sup> @ XFEL	80fs	
e <sup>-</sup> @ LCLS	<75fs	

## Measuring Ultra Short Bunches

### RF Deflection

- Converts time information to spatial information
- Coupled to spectrometer also provides energy information
- Destructive technique
- Resolution down to 1.3 fs
  - X-band RF cavity
  - Linac Coherent Light Source (SLAC)

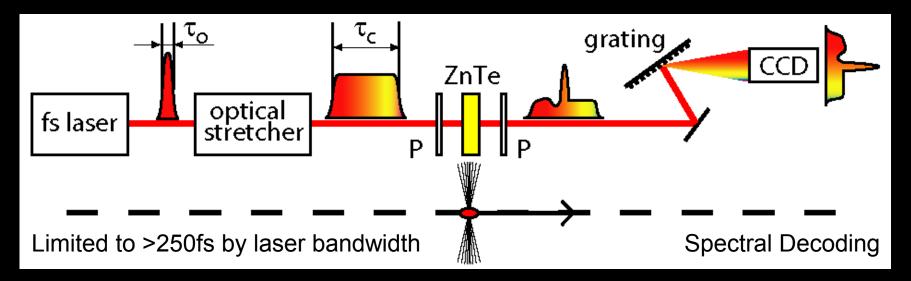




# Measuring Ultra Short Bunches

#### Electro-Optic Sampling

- Use a birefringent crystal to map the electric field of the bunch onto a chirped (time varying wavelength) laser pulse
  - Electric field modified the polarisation of the light in the crystal
- Sample this light pulse to obtain the longitudinal bunch distribution
  - Can be done in a variety of ways
- Non destructive technique
- Resolution down to 30 fs possible



## The Typical Instruments

- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Intensity
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  - wire scanners
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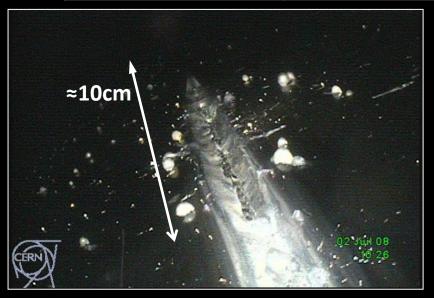
### **Beam Loss Detectors**

#### • Role of a BLM system:

- Protect the machine from damage
- Dump the beam to avoid magnet quenches (for SC magnets)
- Diagnostic tool to improve the performance of the accelerator

### • E.g. LHC

Stored Energy		Quench and Damage at 7 TeV	
Beam 7 TeV	2 x 362 MJ	Quench level	≈ 1mJ/cm <sup>3</sup>
2011 Beam 3.5 TeV	above 2 x 100 MJ	Damage level	≈ 1 J/cm <sup>3</sup>

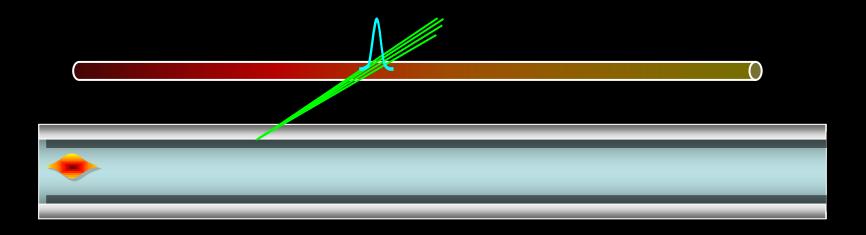


#### SPS incident

- June 2008
- 2 MJ beam lost at 400GeV

## Beam Loss Detectors

- Common types of monitor
  - Long ionisation chamber (charge detection)
    - Up to several km of gas filled hollow coaxial cables
    - Position sensitivity achieved by comparing direct & reflected pulse
      - e.g. SLAC 8m position resolution (30ns) over 3.5km cable length
    - Dynamic range of up to 10<sup>4</sup>
  - Fibre optic monitors
    - Electrical signals replaced by light produced through Cerenkov effect

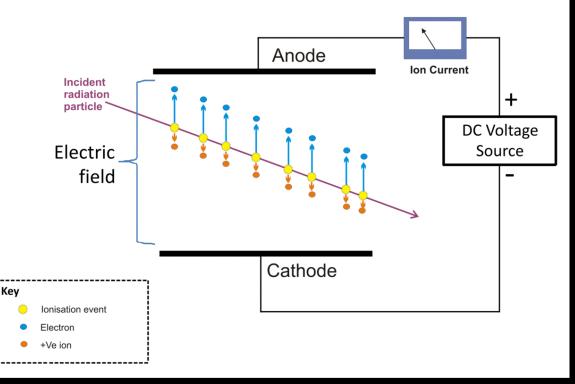


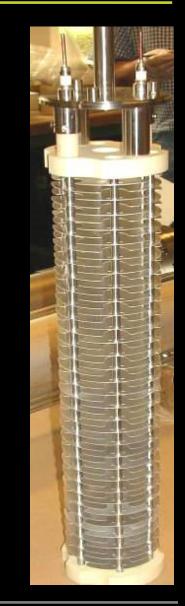
## Beam Loss Detectors

#### Common types of monitor

- Ionisation chambers
- Dynamic range of < 10<sup>8</sup>
- Slow response ( $\mu$ s) due to ion drift time

#### Visualisation of ion chamber operation



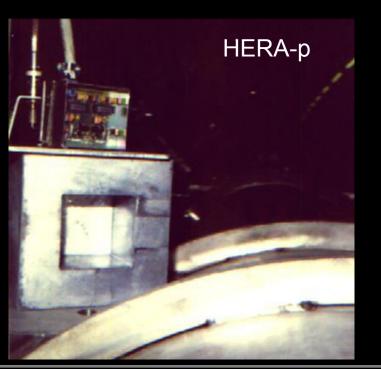


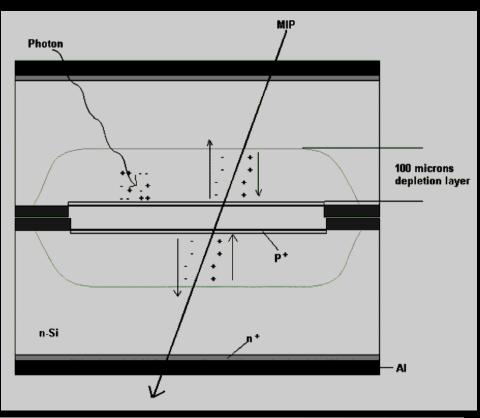
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## **Beam Loss Detectors**

#### Common types of monitor

- PIN photodiode (solid state ionisation chamber)
  - Detect coincidence of ionising particle crossing photodiodes
  - Count rate proportional to beam loss with speed limited by integration time
  - Can distinguish between X-rays & ionising particles
  - Dynamic range of up to 10<sup>9</sup>



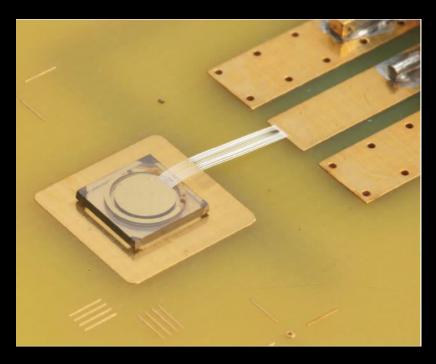


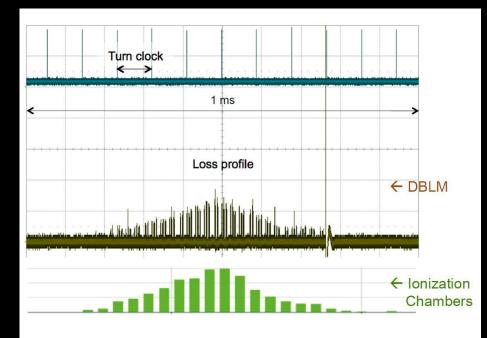
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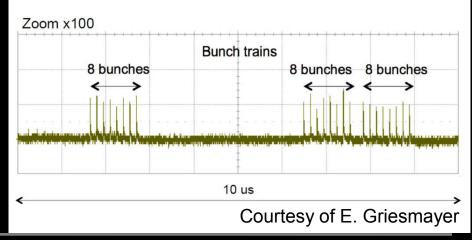
### **Beam Loss Detectors – New Materials**

#### Diamond Detectors

- Fast & sensitive
- Used in LHC to distinguish bunch by bunch losses
- Investigations now ongoing to see if they can work in cryogenic conditions





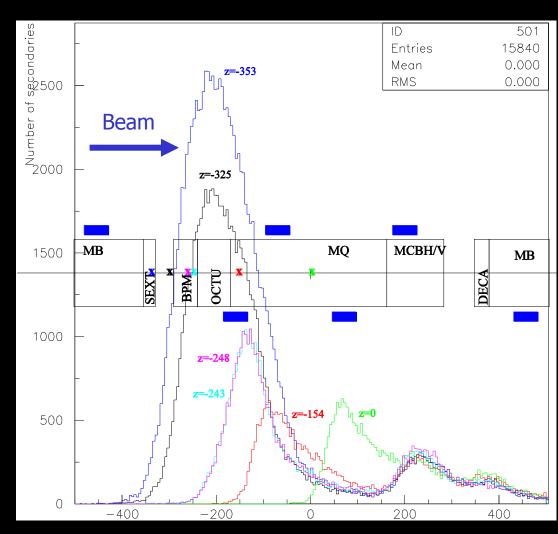


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## Where should we place our BLMs?

- Secondary shower simulation
  - to determine what energy is deposited where
- Impact position varied along quadrupole
- Position of detectors optimized
  - to catch losses & minimize uncertainty of ratio of energy deposition in coil and detector
  - To discriminate between Beams
  - To have good probability that losses are seen by two BLM detectors





### Summary

- This was an overview of the common types of instruments that can be found in most accelerators
  - Only small subset of those currently in use or being developed
  - Many exotic instruments are tailored for specific accelerator needs
- Tomorrow you will see how to use these instruments to run and optimise accelerators
  - Introduction to Accelerator Beam Diagnostics (H. Schmickler)

#### Want to know more? Then Join the afternoon course:

- Beam Instrumentation & Diagnostics
  - For an in-depth analysis of these instruments & their applications
  - 3 Sessions : BPM design & Tune Measurement
    - Using specially developed software & laboratory measurements
  - 2 Sessions : Emittance measurements & ultra-fast diagnostics
  - 1 Session : Design your own beam instrumentation suite
    - Present your Group's ideas on how to equip an accelerator